

# RF Power Field Effect Transistors

## N-Channel Enhancement-Mode Lateral MOSFETs

Designed for broadband commercial and industrial applications with frequencies from 865 to 895 MHz. The high gain and broadband performance of these devices make them ideal for large-signal, common-source amplifier applications in 26 volt base station equipment.

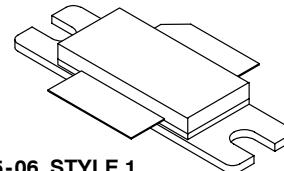
- Typical N-CDMA Performance @ 880 MHz, 26 Volts,  $I_{DQ} = 1100$  mA  
IS-95 CDMA Pilot, Sync, Paging, Traffic Codes 8 Through 13  
Output Power — 25 Watts Avg.  
Power Gain — 17.8 dB  
Efficiency — 25%  
Adjacent Channel Power —  
750 kHz: -47 dBc @ 30 kHz BW
- Capable of Handling 10:1 VSWR, @ 26 Vdc, 880 MHz, 135 Watts CW  
Output Power

### Features

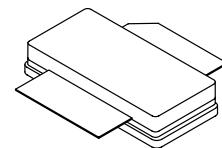
- Internally Matched for Ease of Use
- High Gain, High Efficiency and High Linearity
- Integrated ESD Protection
- Designed for Maximum Gain and Insertion Phase Flatness
- Excellent Thermal Stability
- Characterized with Series Equivalent Large-Signal Impedance Parameters
- Low Gold Plating Thickness on Leads,  $40\mu$ " Nominal.
- RoHS Compliant
- In Tape and Reel. R3 Suffix = 250 Units per 32 mm, 13 inch Reel.

### MRF9135LR3 MRF9135LSR3

880 MHz, 135 W, 26 V  
LATERAL N-CHANNEL  
RF POWER MOSFETs



CASE 465-06, STYLE 1  
NI-780  
MRF9135LR3



CASE 465A-06, STYLE 1  
NI-780S  
MRF9135LSR3

**Table 1. Maximum Ratings**

Rating	Symbol	Value	Unit
Drain-Source Voltage	$V_{DSS}$	- 0.5, +65	Vdc
Gate-Source Voltage	$V_{GS}$	- 0.5, +15	Vdc
Total Device Dissipation @ $T_C = 25^\circ C$ Derate above $25^\circ C$	$P_D$	298 1.7	W W/ $^\circ C$
Storage Temperature Range	$T_{stg}$	- 65 to +200	$^\circ C$
Case Operating Temperature	$T_C$	150	$^\circ C$
Operating Junction Temperature	$T_J$	200	$^\circ C$

**Table 2. Thermal Characteristics**

Characteristic	Symbol	Value (1)	Unit
Thermal Resistance, Junction to Case	$R_{\theta JC}$	0.6	$^\circ C/W$

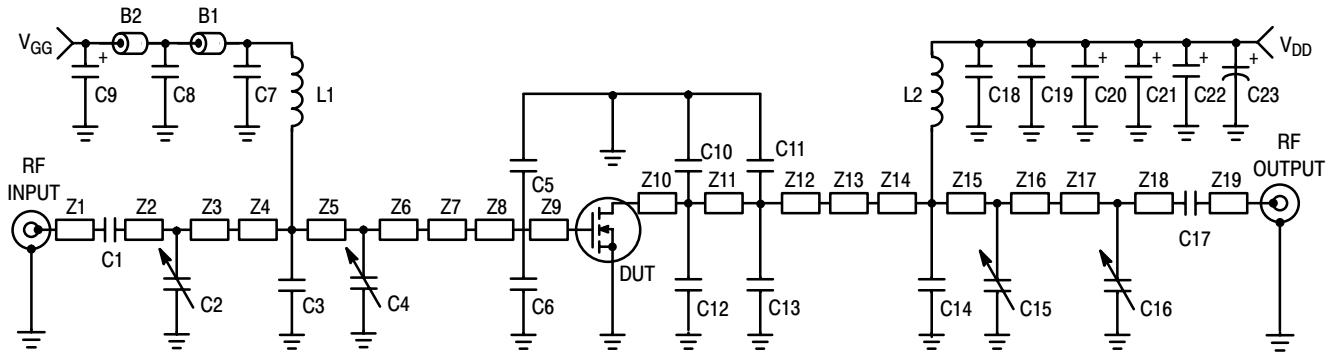
**Table 3. ESD Protection Characteristics**

Test Conditions	Class
Human Body Model	1 (Minimum)
Machine Model	M2 (Minimum)
Charge Device Model	C7 (Minimum)

- MTTF calculator available at <http://www.freescale.com/rf>. Select Tools/Software/Application Software/Calculators to access the MTTF calculators by product.

**Table 4. Electrical Characteristics** ( $T_C = 25^\circ\text{C}$ , 50 ohm system unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
<b>Off Characteristics</b>					
Zero Gate Voltage Drain Leakage Current ( $V_{DS} = 65 \text{ Vdc}$ , $V_{GS} = 0 \text{ Vdc}$ )	$I_{DSS}$	—	—	10	$\mu\text{A}$
Zero Gate Voltage Drain Leakage Current ( $V_{DS} = 26 \text{ Vdc}$ , $V_{GS} = 0 \text{ Vdc}$ )	$I_{DSS}$	—	—	1	$\mu\text{A}$
Gate-Source Leakage Current ( $V_{GS} = 5 \text{ Vdc}$ , $V_{DS} = 0 \text{ Vdc}$ )	$I_{GSS}$	—	—	1	$\mu\text{A}$
<b>On Characteristics</b>					
Gate Threshold Voltage ( $V_{DS} = 10 \text{ Vdc}$ , $I_D = 450 \mu\text{A}$ )	$V_{GS(\text{th})}$	2	2.8	4	Vdc
Gate Quiescent Voltage ( $V_{DS} = 26 \text{ Vdc}$ , $I_D = 1100 \text{ mA}$ )	$V_{GS(Q)}$	3.25	3.7	5	Vdc
Drain-Source On-Voltage ( $V_{GS} = 10 \text{ Vdc}$ , $I_D = 3 \text{ A}$ )	$V_{DS(\text{on})}$	—	0.19	0.4	Vdc
Forward Transconductance ( $V_{DS} = 10 \text{ Vdc}$ , $I_D = 9 \text{ A}$ )	$g_{fs}$	—	12	—	S
<b>Dynamic Characteristics</b>					
Output Capacitance ( $V_{DS} = 26 \text{ Vdc} \pm 30 \text{ mV(rms)}$ ac @ 1 MHz, $V_{GS} = 0 \text{ Vdc}$ )	$C_{oss}$	—	109	—	pF
Reverse Transfer Capacitance ( $V_{DS} = 26 \text{ Vdc} \pm 30 \text{ mV(rms)}$ ac @ 1 MHz, $V_{GS} = 0 \text{ Vdc}$ )	$C_{rss}$	—	4.4	—	pF
<b>Functional Tests</b> (In Freescale Test Fixture, 50 ohm system) Single-Carrier N-CDMA, 1.2288 MHz Channel Bandwidth Carrier, PAR = 9.8 dB @ 0.01% Probability on CCDF					
Common-Source Amplifier Power Gain ( $V_{DD} = 26 \text{ Vdc}$ , $P_{out} = 25 \text{ W}$ Avg. N-CDMA, $I_{DQ} = 1100 \text{ mA}$ , f = 880.0 MHz)	$G_{ps}$	16	17.8	—	dB
Drain Efficiency ( $V_{DD} = 26 \text{ Vdc}$ , $P_{out} = 25 \text{ W}$ Avg. N-CDMA, $I_{DQ} = 1100 \text{ mA}$ , f = 880.0 MHz)	n	22	25	—	%
Adjacent Channel Power Ratio ( $V_{DD} = 26 \text{ Vdc}$ , $P_{out} = 25 \text{ W}$ Avg. N-CDMA, $I_{DQ} = 1100 \text{ mA}$ , f = 880.0 MHz; ACPR @ 25 W, 1.23 MHz Bandwidth, 750 kHz Channel Spacing)	ACPR	—	-47	-45	dBc
Input Return Loss ( $V_{DD} = 26 \text{ Vdc}$ , $P_{out} = 25 \text{ W}$ Avg. N-CDMA, $I_{DQ} = 1100 \text{ mA}$ , f = 880.0 MHz)	IRL	—	-13.5	-9	dB
Common-Source Amplifier Power Gain ( $V_{DD} = 26 \text{ Vdc}$ , $P_{out} = 25 \text{ W}$ Avg. N-CDMA, $I_{DQ} = 1100 \text{ mA}$ , f = 865 MHz and 895 MHz)	$G_{ps}$	—	17	—	dB
Drain Efficiency ( $V_{DD} = 26 \text{ Vdc}$ , $P_{out} = 25 \text{ W}$ Avg. N-CDMA, $I_{DQ} = 1100 \text{ mA}$ , f = 865 MHz and 895 MHz)	n	—	24	—	%
Adjacent Channel Power Ratio ( $V_{DD} = 26 \text{ Vdc}$ , $P_{out} = 25 \text{ W}$ Avg. N-CDMA, $I_{DQ} = 1100 \text{ mA}$ , f = 865 MHz and 895 MHz; ACPR @ 25 W, 1.23 MHz Bandwidth, 750 kHz Channel Spacing)	ACPR	—	-46	—	dBc
Input Return Loss ( $V_{DD} = 26 \text{ Vdc}$ , $P_{out} = 25 \text{ W}$ Avg. N-CDMA, $I_{DQ} = 1100 \text{ mA}$ , f = 865 MHz and 895 MHz)	IRL	—	-12.5	—	dB

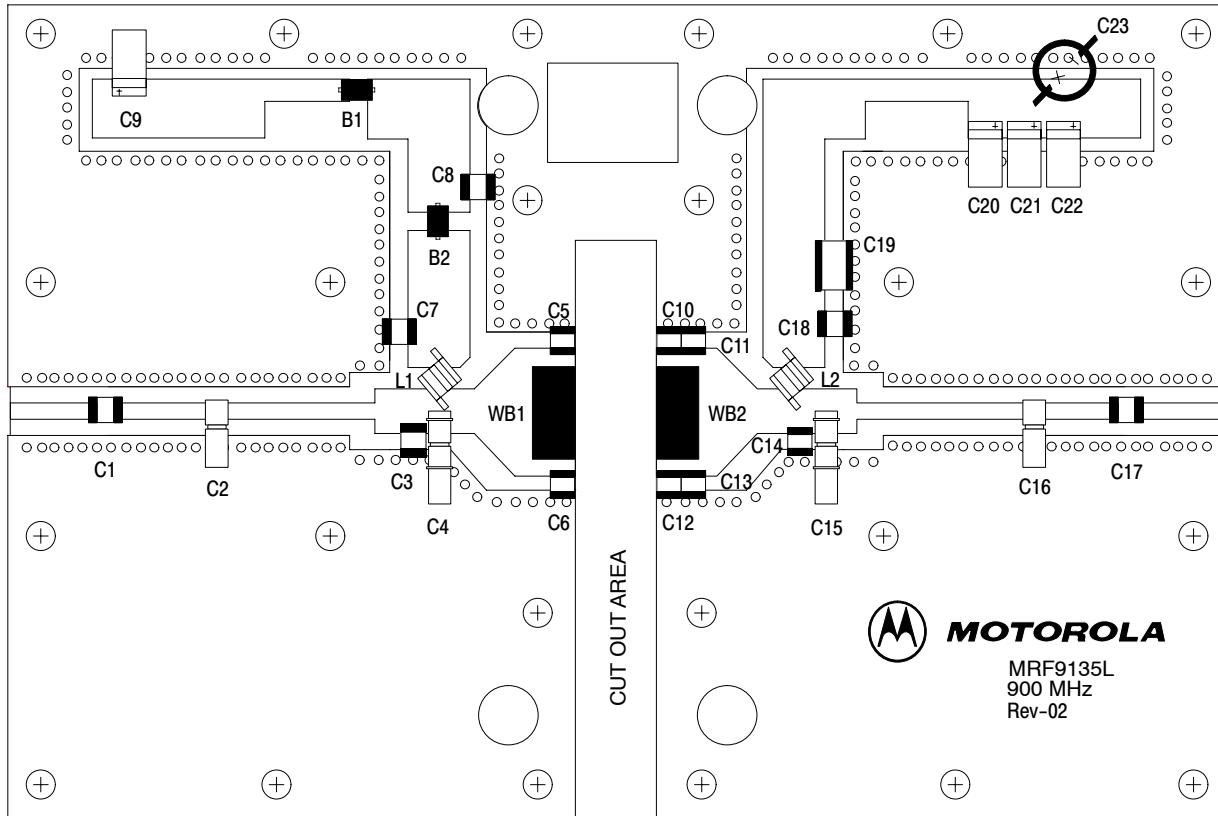


Z1	0.430" x 0.080" Microstrip	Z11	0.105" x 0.630" Microstrip
Z2	0.430" x 0.080" Microstrip	Z12	0.145" x 0.630" Microstrip
Z3	0.800" x 0.080" Microstrip	Z13	0.200" x 0.630" x 0.220" Taper
Z4	0.200" x 0.220" Microstrip	Z14	0.180" x 0.220" Microstrip
Z5	0.110" x 0.220" Microstrip	Z15	0.110" x 0.220" Microstrip
Z6	0.175" x 0.220" Microstrip	Z16	0.200" x 0.220" Microstrip
Z7	0.200" x 0.220" x 0.630" Taper	Z17	0.900" x 0.080" Microstrip
Z8	0.250" x 0.630" Microstrip	Z18	0.360" x 0.080" Microstrip
Z9	0.050" x 0.630" Microstrip	Z19	0.410" x 0.080" Microstrip
Z10	0.050" x 0.630" Microstrip	PCB	Arlon GX-0300-55-22, 0.030", $\epsilon_r = 2.55$

Figure 1. 880 MHz Test Circuit Schematic

Table 5. 880 MHz Test Circuit Component Designations and Values

Part	Description	Part Number	Manufacturer
B1, B2	Ferrite Beads, Short	2743019447	Fair Rite
C1, C7, C17, C18	47 pF Chip Capacitors	100B470JP 500X	ATC
C2, C16	0.6-4.5 Variable Capacitors, Gigatrim	27271SL	Johanson
C3	8.2 pF Chip Capacitor	100B8R2BP 500X	ATC
C4, C15	0.8-8.0 Variable Capacitors, Gigatrim	27291SL	Johanson
C5, C6	12 pF Chip Capacitors	100B120JP 500X	ATC
C8	20K pF Chip Capacitor	200B203MP50X	ATC
C9, C20, C21, C22	10 $\mu$ F, 35 V Tantalum Capacitors	T491D106K035AS	Kemet
C10, C11, C12, C13	7.5 pF Chip Capacitors	100B7R5JP 500X	ATC
C14	11 pF Chip Capacitor	100B110JP 500X	ATC
C19	0.56 $\mu$ F, 50 V Chip Capacitor	C1825C564K5RA7800	Kemet
C23	470 $\mu$ F, 63 V Electrolytic Capacitor	SME63VB471M12X25LL	United Chemi-Con
L1, L2	12.5 nH Coilcraft inductors	A04T-5	Coilcraft
WB1, WB2	10 mil Brass Shim (0.205 x 0.530)	RF-Design Lab	RF-Design Lab



Freescale has begun the transition of marking Printed Circuit Boards (PCBs) with the Freescale Semiconductor signature/logo. PCBs may have either Motorola or Freescale markings during the transition period. These changes will have no impact on form, fit or function of the current product.

**Figure 2. 880 MHz Test Circuit Component Layout**

## TYPICAL CHARACTERISTICS

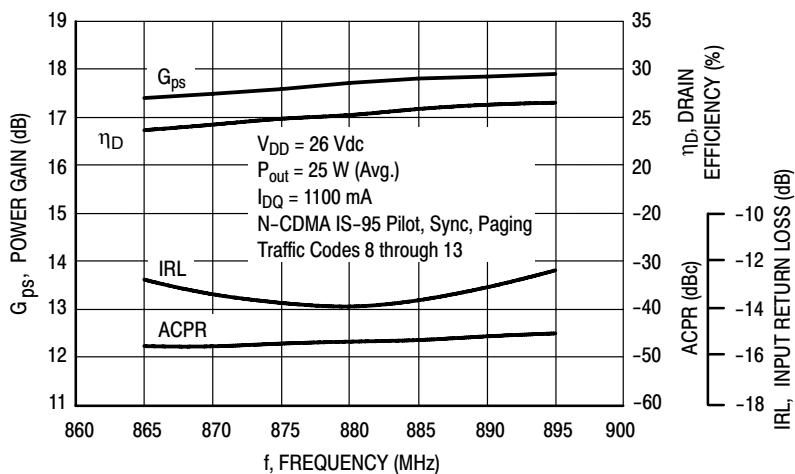


Figure 3. Class AB Broadband Circuit Performance

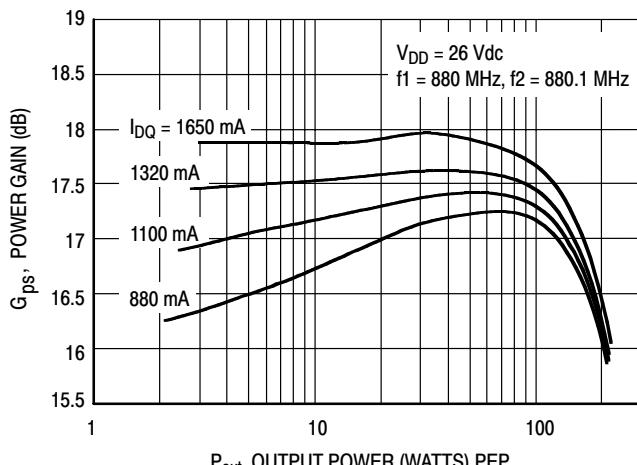


Figure 4. Power Gain versus Output Power

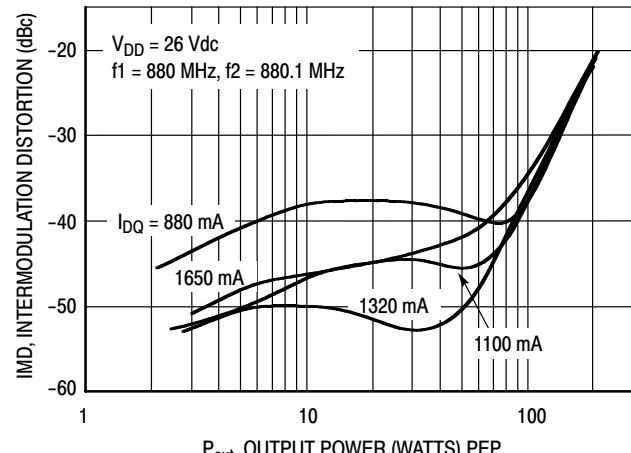


Figure 5. Intermodulation Distortion versus Output Power

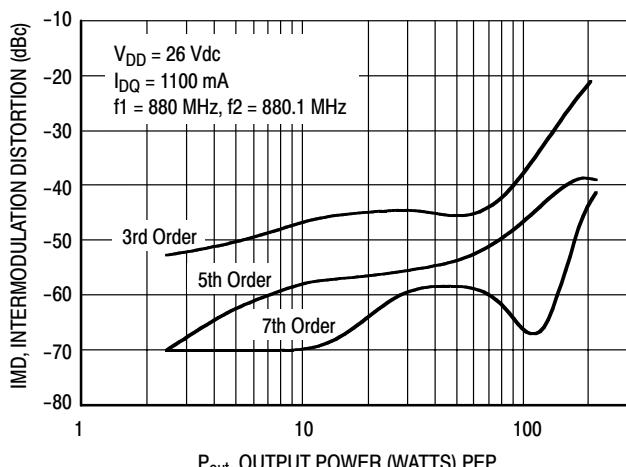


Figure 6. Intermodulation Distortion Products versus Output Power

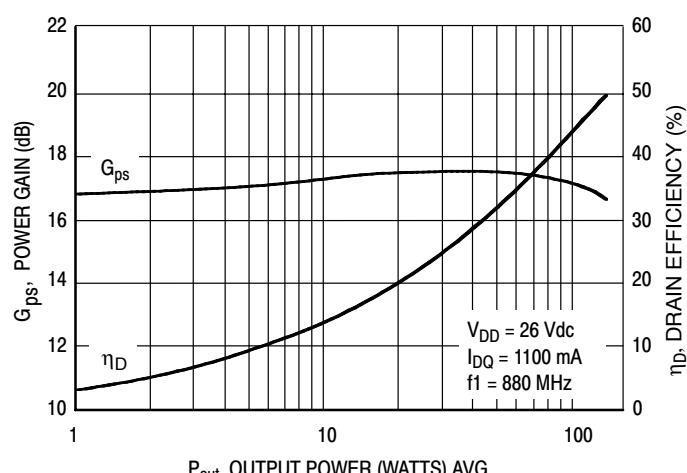


Figure 7. Power Gain and Efficiency versus Output Power

## TYPICAL CHARACTERISTICS

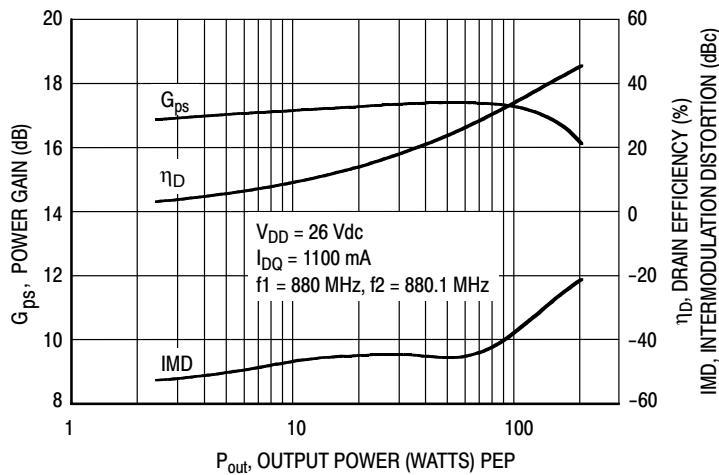


Figure 8. Power Gain, Efficiency and IMD versus Output Power

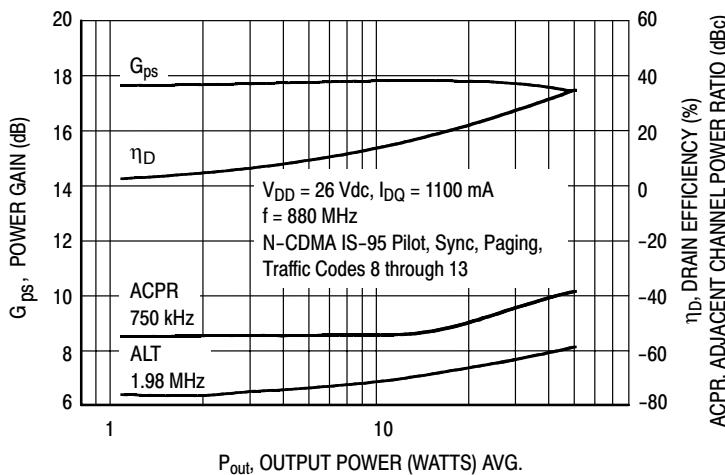
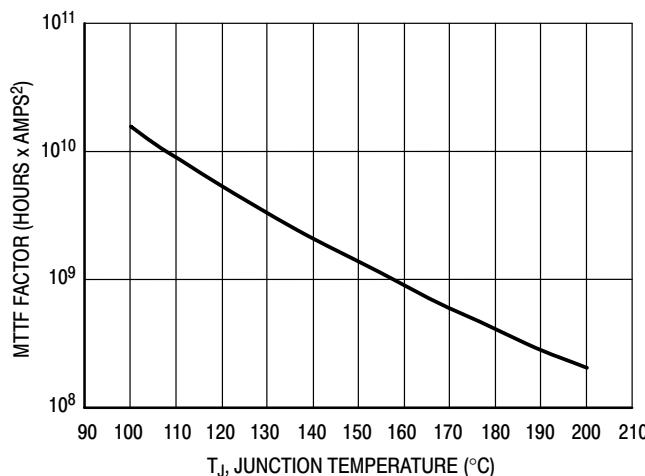
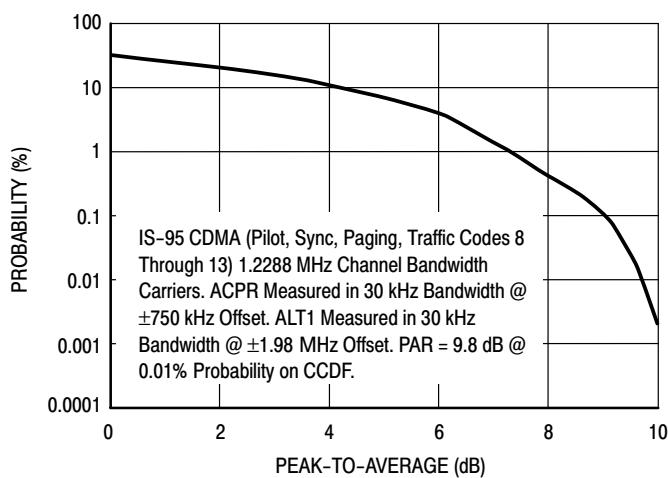
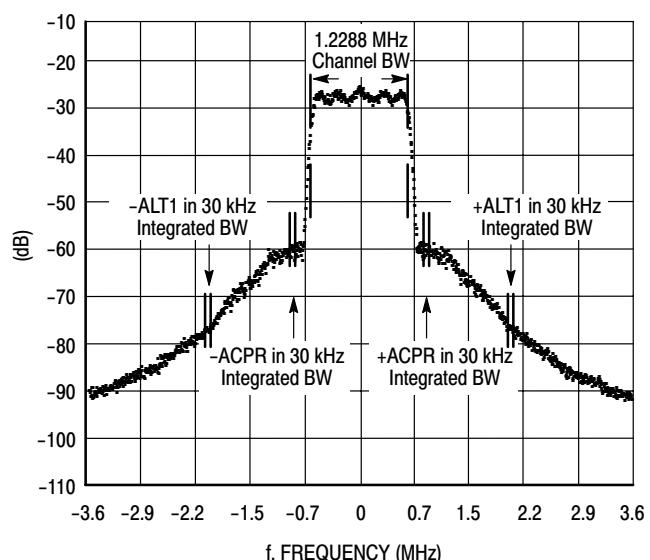


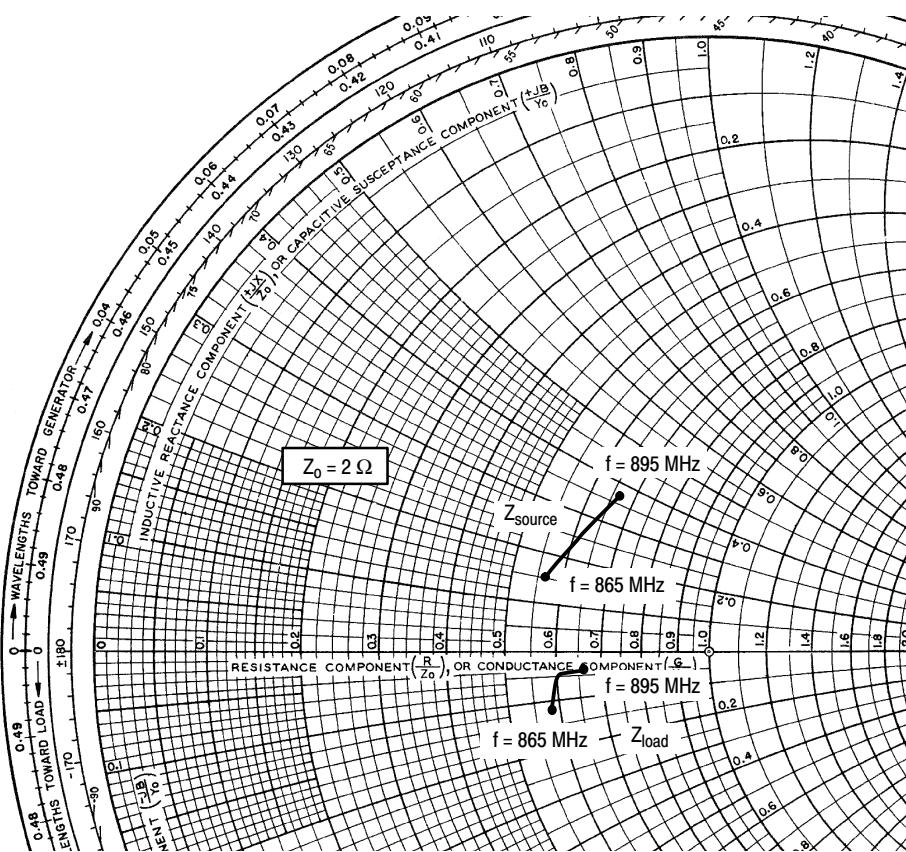
Figure 9. N-CDMA Performance Output Power versus Gain, ACPR, Efficiency



This above graph displays calculated MTTF in hours x ampere<sup>2</sup> drain current. Life tests at elevated temperatures have correlated to better than  $\pm 10\%$  of the theoretical prediction for metal failure. Divide MTTF factor by  $I_D^2$  for MTTF in a particular application.

Figure 10. MTTF Factor versus Junction Temperature

**N-CDMA TEST SIGNAL****Figure 11. Single-Carrier CCDF N-CDMA****Figure 12. Single-Carrier N-CDMA Spectrum**



$V_{DD} = 26 \text{ V}$ ,  $I_{DQ} = 1100 \text{ mA}$ ,  $P_{\text{out}} = 25 \text{ W Avg.}$

$f$ MHz	$Z_{\text{source}}$ $\Omega$	$Z_{\text{load}}$ $\Omega$
865	$1.15 + j0.3$	$1.17 - j0.24$
880	$1.25 + j0.5$	$1.22 - j0.1$
895	$1.35 + j0.75$	$1.32 - j0.07$

$Z_{\text{source}}$  = Test circuit impedance as measured from gate to ground.

$Z_{\text{load}}$  = Test circuit impedance as measured from drain to ground.

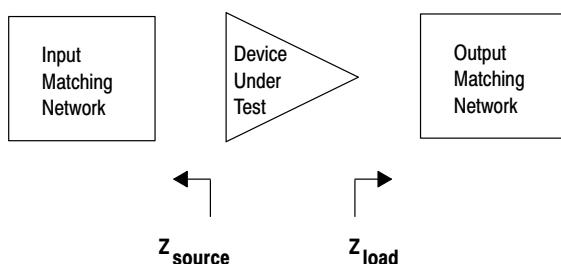


Figure 13. Series Equivalent Source and Load Impedance

## NOTES

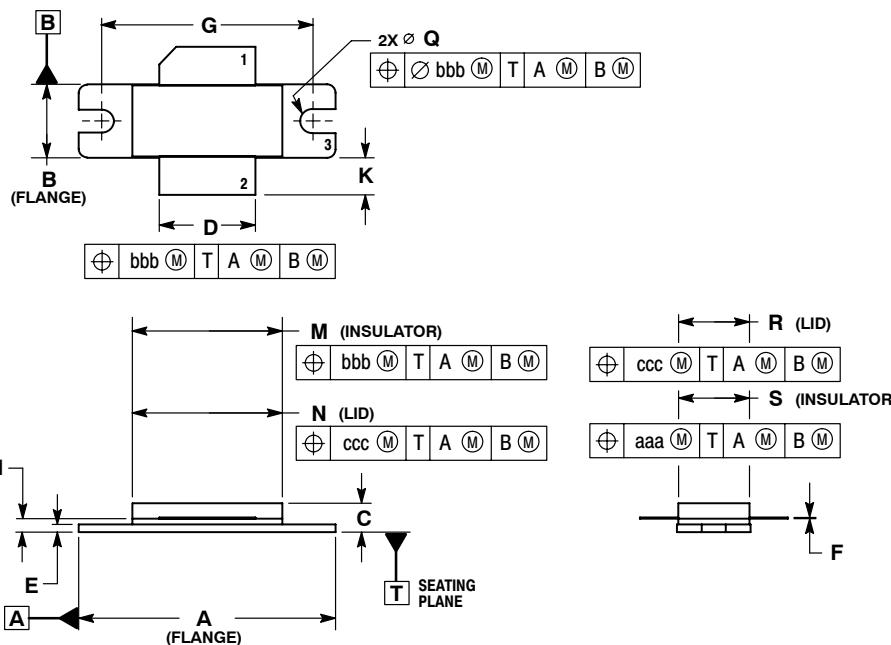
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MRF9135LR3 MRF9135LSR3

## NOTES

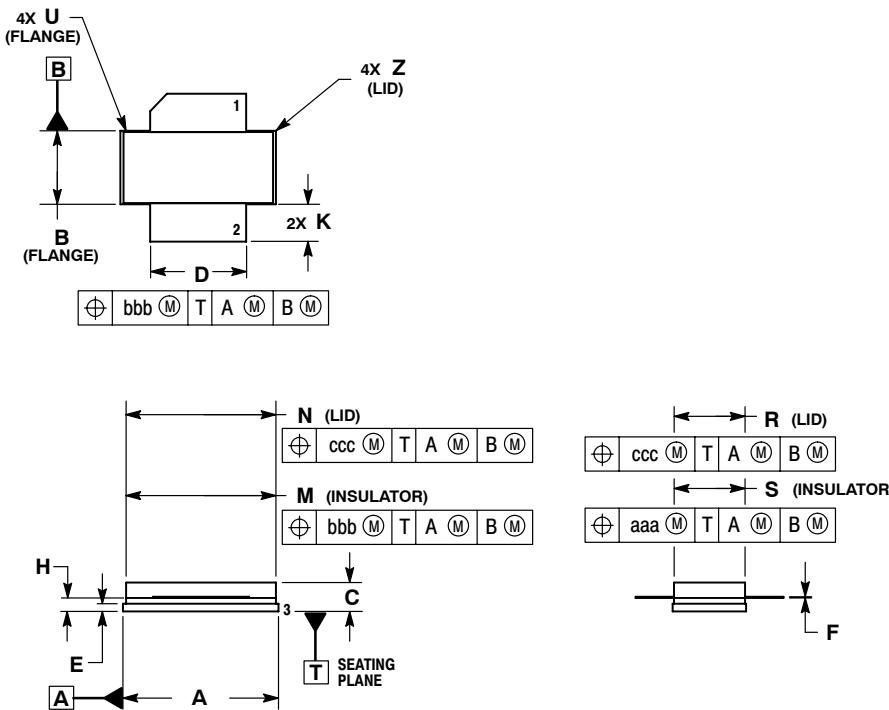
## PACKAGE DIMENSIONS



CASE 465-06  
ISSUE G  
NI-780  
MRF9135LR3

DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	1.335	1.345	33.91	34.16
B	0.380	0.390	9.65	9.91
C	0.125	0.170	3.18	4.32
D	0.495	0.505	12.57	12.83
E	0.035	0.045	0.89	1.14
F	0.003	0.006	0.08	0.15
G	1.100	BSC	27.94	BSC
H	0.057	0.067	1.45	1.70
K	0.170	0.210	4.32	5.33
M	0.774	0.786	19.66	19.96
N	0.772	0.788	19.60	20.00
Q	Ø 0.118	Ø 0.138	Ø 3.00	Ø 3.51
R	0.365	0.375	9.27	9.53
S	0.365	0.375	9.27	9.52
aaa	0.005	REF	0.127	REF
bbb	0.010	REF	0.254	REF
ccc	0.015	REF	0.381	REF

STYLE 1:  
PIN 1. DRAIN  
2. GATE  
3. SOURCE



CASE 465A-06  
ISSUE H  
NI-780S  
MRF9135LSR3

DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	0.805	0.815	20.45	20.70
B	0.380	0.390	9.65	9.91
C	0.125	0.170	3.18	4.32
D	0.495	0.505	12.57	12.83
E	0.035	0.045	0.89	1.14
F	0.003	0.006	0.08	0.15
H	0.057	0.067	1.45	1.70
K	0.170	0.210	4.32	5.33
M	0.774	0.786	19.61	20.02
N	0.772	0.788	19.61	20.02
R	0.365	0.375	9.27	9.53
S	0.365	0.375	9.27	9.52
U	---	0.040	---	1.02
Z	---	0.030	---	0.76
aaa	0.005	REF	0.127	REF
bbb	0.010	REF	0.254	REF
ccc	0.015	REF	0.381	REF

STYLE 1:  
PIN 1. DRAIN  
2. GATE  
5. SOURCE

MRF9135LR3 MRF9135LSR3

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